

Lonten P-channel -30V, -4.0A, 50mΩ Power MOSFET

Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- \bullet -30V,-4.0A,R_{DS(ON).max}=50m Ω @V_{GS}=-10V
- ♦ Improved dv/dt capability
- Fast switching
- Green device available

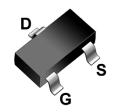
Applications

- PWM applications
- Load switch
- Portable Equipment

Product Summary

 $\begin{array}{ll} V_{DSS} & -30V \\ R_{DS(on).max} \textcircled{0} \ V_{GS} \text{=-}10V & 50m\Omega \\ I_D & -4.0A \end{array}$

Pin Configuration





SOT-23-3

P-Channel MOSFET



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{ t DSS}$	-30	V
Continuous drain current (T _A = 25°C)		-4.0	А
Continuous drain current (T _A = 100°C)	I _D	-2.5	A
Pulsed drain current ¹⁾	I _{DM}	-16.0	А
Gate-Source voltage	V_{GSS}	±12	V
Power Dissipation (T _A = 25°C)	P _D	1.2	W
Storage Temperature Range	T _{STG}	-55 to +150	°C
Operating Junction Temperature Range	$T_\mathtt{J}$	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JA}$	104	°C/W



Package Marking and Ordering Information

Device	Device Package	Marking
LPSA3481	SOT-23-3	3481

Electrical Characteristics T_J = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =-250uA	-30			V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250uA	-0.6	-0.95	-1.3	V
Drain-source leakage current		V _{DS} =-30 V, V _{GS} =0 V, T _J = 25°C			-1	μΑ
	I _{DSS}	V _{DS} =-24V, V _{GS} =0 V, T _J = 125°C			-10	μΑ
Gate leakage current, Forward	I _{GSSF}	V _{GS} =12 V, V _{DS} =0 V			100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-12 V, V _{DS} =0 V			-100	nA
		V _{GS} =-10 V, I _D =-4 A		41	50	mΩ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =-4.5 V, I _D =-3.5A		47	60	mΩ
		V _{GS} =-2.5 V, I _D =-2.5A		60	85	mΩ
Forward transconductance	g _{fs}	$V_{DS} = -5 \text{ V}$, $I_{D} = -4.0 \text{A}$		15		S
Dynamic characteristics	·			•		
Input capacitance	C _{iss}			1180		
Output capacitance	Coss	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ $F = 1 \text{MHz}$		80		pF
Reverse transfer capacitance	C _{rss}	- 1 - 11/11/2		68		
Turn-on delay time	t _{d(on)}			1.8		ns
Rise time	t _r	$V_{DD} = -15V, V_{GS} = -10V, I_D = -4A,$		30.2		
Turn-off delay time	t _{d(off)}	Rg=3Ω		52.5		
Fall time	t _f			7.3		
Gate resistance	Rg	V _{GS} =0V,V _{DS} =0V,f=1MHz		11.5		Ω
Gate charge characteristics						
Gate to source charge	Q _{gs}			2.1		
Gate to drain charge	Q_{gd}	V_{DS} =-15 V, I_{D} =-4.0A, V_{GS} =-10 V		2.3		nC
Gate charge total	Qg	- VGS10 V		19.3		
Drain-Source diode characteris	ics and Maxi	mum Ratings				
Continuous Source Current	Is				-4.0	А
Pulsed Source Current ²⁾	I _{SM}				-16.0	Α
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =-2A, T _J =25℃			-1.2	V
		1		1	1	<u> </u>

Notes:

^{1:} Repetitive Rating: Pulse width limited by maximum junction temperature.

^{2:} Pulse Test: Pulse Width $\leq 300 \,\mu$ s, Duty Cycle $\leq 2\%$.



Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

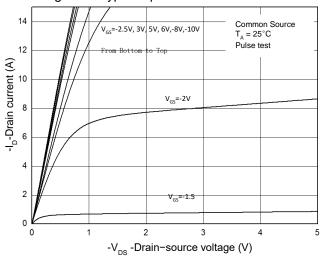


Figure 2. Transfer Characteristics

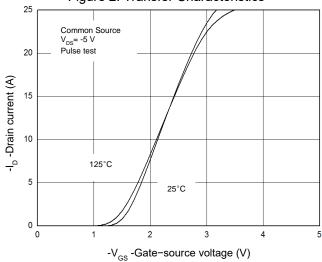


Figure 3. Capacitance Characteristics

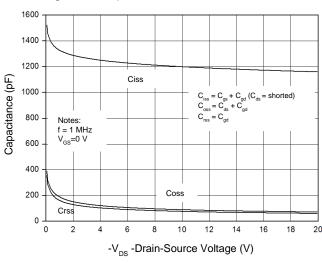


Figure 4. Gate Charge Waveform

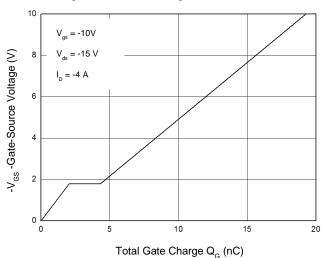


Figure 5. Body-Diode Characteristics

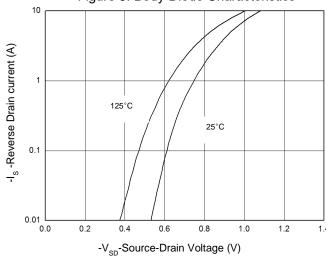
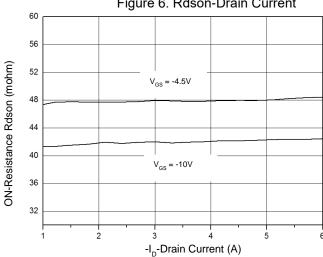


Figure 6. Rdson-Drain Current





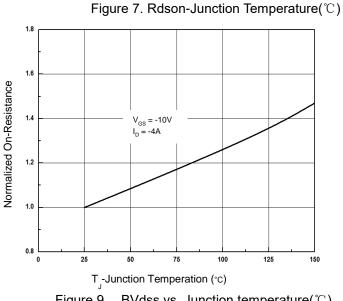


Figure 9. BVdss vs. Junction temperature(℃)

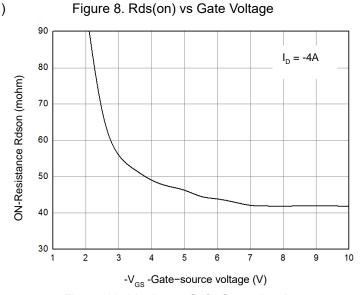
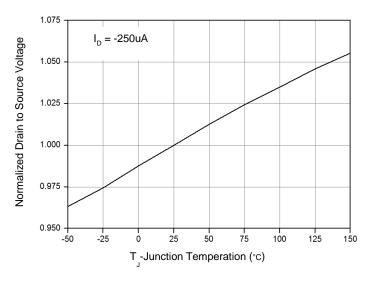


Figure 10. Maximum Safe Operating Area



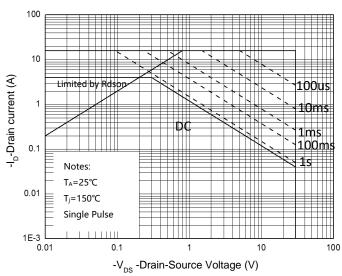
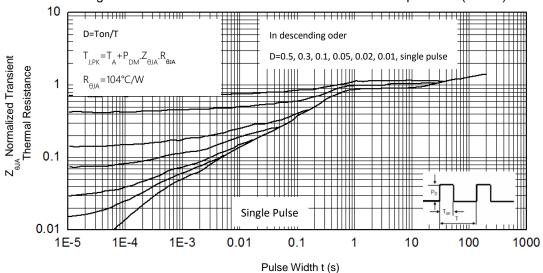


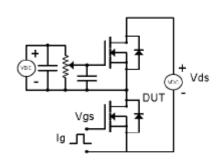
Figure 11. Normalized Maximum Transient Thermal Impedance (RthJA)





Test Circuit & Waveform

Figure 8. Gate Charge Test Circuit & Waveform



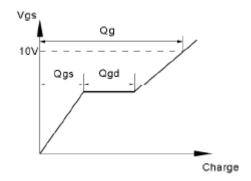
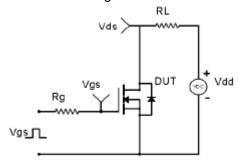


Figure 9. Resistive Switching Test Circuit & Waveforms



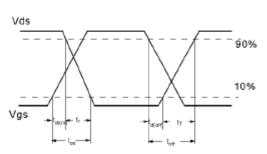
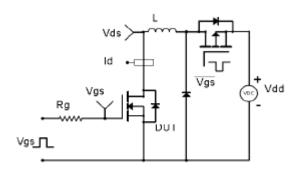


Figure 10. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



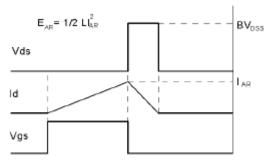
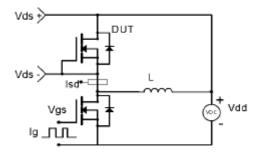
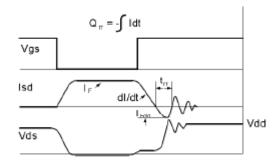


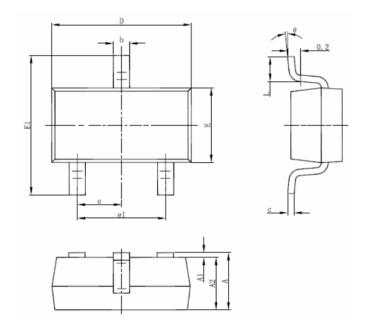
Figure 11. Diode Recovery Circuit & Waveform





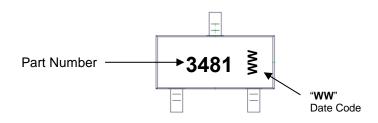


Mechanical Dimensions for SOT-23-3



COMMON DIMENSIONS					
SYMBOL	MILLIMETERS		INCHS		
	MIN	MAX	MIN	MAX	
Α	1.00	1.30	0.039	0.051	
A1	0.00	0.10	0.000	0.004	
A2	1.00	1.20	0.039	0.047	
b	0.30	0.50	0.012	0.020	
С	0.04	0.21	0.002	0.008	
D	2.80	3.00	0.110	0.118	
Е	1.50	1.70	0.059	0.067	
E1	2.60	3.00	0.102	0.118	
е	0.95 TYP.		0.037 TYP.		
e1	1.90 TYP.		0.075 TYP.		
L	0.25	0.55	0.010	0.022	
θ	0°	8°	0°	8°	

SOT-23-3 Part Marking Information





Disclaimer

The content specified herein is for the purpose of introducing LONTEN's products (hereinafter "Products"). The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. Examples of application circuits, circuit constants and any other information contained herein illustrate the standard usage and operations of the Products. The peripheral conditions must be taken into account when designing circuits for mass production.

LONTEN does not assume any liability for infringement of patents, copyrights, or other intellectual property rights of third parties by or arising from the use of the Products or technical information described in this document.

The Products are not designed or manufactured to be used with any equipment, device or system which requires an extremely high level of reliability the failure or malfunction of which may result in a direct threat to human life or create a risk of human injury (such as a medical instrument, transportation equipment, aerospace machinery, nuclear-reactor controller, fuel-controller or other safety device). LONTEN shall bear no responsibility in any way for use of any of the Products for the above special purposes.

Although LONTEN endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a LONTEN product.

The content specified herein is subject to change for improvement without notice. When using a LONTEN product, be sure to obtain the latest specifications.

Version 1.2, May-2019 7 www.lonten.cc

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by LONTEN manufacturer:

Other Similar products are found below:

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3